

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

PRIORITY DOCKET NO.

242927US90

SERIAL NO.

10/663,730

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hajime NOTO, et al.

FILING DATE

September 17, 2003

GROUP

2873

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
SCC	AA	5,923,380	07/13/1999	Yibing YANG, et al.			
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
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	AQ					
	AR					
	AS					
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	AU					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

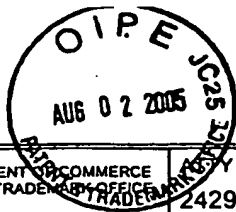
/Sheela Chawan/

Date Considered

12/26/2006

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<div style="position: relative; width: 100px; height: 100px; margin: 0 auto;"> <div style="position: absolute; top: 0; left: 0; right: 0; bottom: 0; border: 1px solid black; border-radius: 50%; text-align: center; line-height: 100px;"> OIPE JUL 05 2005 PATENT & TRADEMARK OFFICE </div> </div>				APPLICANT Hajime NOTO, et al.			
				FILING DATE September 17, 2003		GROUP 2873	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
SCC	AW	C. Marc BASTUSCHECK, "Techniques for Real-time Generation of Range Images", IEEE Computer Society Conference, XP-010016459, June 4, 1989, pages 262-268					
↓	AX	C. Marc BASTUSCHECK, et al., "Object Recognition by Three-Dimensional Curve Matching", International Journal of Intelligent Systems, vol. 1, XP-009047871, 1986, pages 105-132,					
↓	AY	Brian CARRIHILL, et al., "Experiments with the Intensity Ratio Depth Sensor", Computer Vision, Graphics and Image Processing, vol. 32, XP-009047858, 1985, pages 337-358					
↓	AZ	Jose R. A. TORREAO, "A New Approach to Photometric Stereo", ELSEVIER, Pattern Recognition Letters, vol. 20, no. 5, XP-004169879, May 1999, Pages 535-540				<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Sheela Chawan/					Date Considered 12/26/2006		
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
SCC	AO	2000-146543	05/26/2000	Japan (with English Abstract)		x
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

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